

Product data sheet

### 1. General description

PNP low  $V_{CEsat}$  Breakthrough In Small Signal (BISS) transistor in a leadless ultra small DFN1010D-3 (SOT1215) Surface-Mounted Device (SMD) plastic package with visible and solderable side pads.

NPN complement: PBSS4130QA.

### 2. Features and benefits

- Very low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High collector current gain h<sub>FE</sub> at high I<sub>C</sub>
- High energy efficiency due to less heat generation
- Reduced Printed-Circuit Board (PCB) area requirements
- Solderable side pads
- AEC-Q101 qualified

### 3. Applications

- Loadswitch
- Battery-driven devices
- Power management
- Charging circuits
- Power switches (e.g. motors, fans)

### 4. Quick reference data

Table 1. Qui	ck reference data					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CEO</sub>	collector-emitter voltage	open base	-	-	-30	V
I <sub>C</sub>	collector current		-	-	-1	А
I <sub>CM</sub>	peak collector current	$t_p \le 1 ms; pulsed$	-	-	-1.5	А
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_{C}$ = -1 A; $I_{B}$ = -100 mA; pulsed; $t_{p}$ ≤ 300 μs; δ ≤ 0.02 ; $T_{amb}$ = 25 °C	-	160	240	mΩ





30 V, 1 A PNP low VCEsat (BISS) transistor

## 5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	В	base		С
2	Е	emitter		вщ
3	С	collector	4 3	۲۰۰۰) 
4	С	collector	2 Transparent top view	sym132
			DFN1010D-3 (SOT1215)	

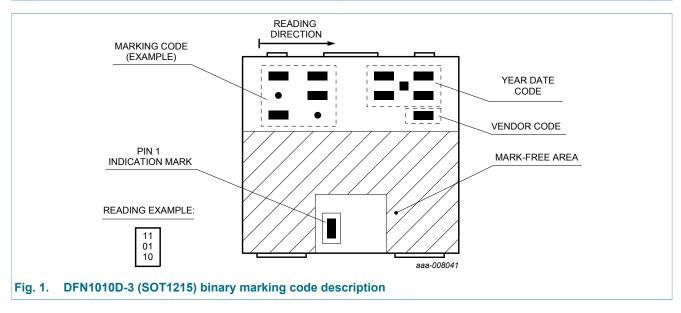
## 6. Ordering information

Table 3. Ordering information						
Type number	Package					
	Name	Description	Version			
PBSS5130QA	DFN1010D-3	plastic thermal enhanced ultra thin small outline package; no leads; 3 terminals	SOT1215			

## 7. Marking

#### Table 4. Marking codes

Type number	Marking code
PBSS5130QA	00 10 10



30 V, 1 A PNP low VCEsat (BISS) transistor

### 8. Limiting values

#### Table 5.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Мах	Unit
V <sub>CBO</sub>	collector-base voltage	open emitter		-	-30	V
V <sub>CEO</sub>	collector-emitter voltage	open base		-	-30	V
V <sub>EBO</sub>	emitter-base voltage	open collector		-	-7	V
I <sub>C</sub>	collector current			-	-1	А
I <sub>CM</sub>	peak collector current	$t_p \le 1 ms$ ; pulsed		-	-1.5	А
I <sub>B</sub>	base current			-	-0.3	А
I <sub>BM</sub>	peak base current	$t_p \le 1 ms; pulsed$		-	-1	А
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C	[1]	-	325	mW
			[2]	-	600	mW
			[3]	-	740	mW
			[4]	-	540	mW
			[5]	-	1000	mW
Tj	junction temperature			-	150	°C
T <sub>amb</sub>	ambient temperature			-55	150	°C
T <sub>stg</sub>	storage temperature			-65	150	°C

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 1 cm<sup>2</sup>.

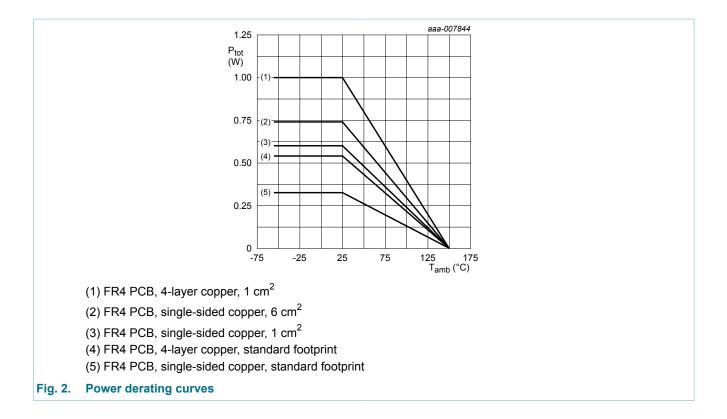
[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 6 cm<sup>2</sup>.

[4] Device mounted on an FR4 PCB, 4-layer copper, tin-plated and standard footprint.

<sup>[5]</sup> Device mounted on an FR4 PCB, 4-layer copper, tin-plated mounting pad for collector 1 cm<sup>2</sup>.

## PBSS5130QA

#### 30 V, 1 A PNP low VCEsat (BISS) transistor



### 9. Thermal characteristics

Table 6. Thermal characteristics							
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R <sub>th(j-a)</sub>		in free air	[1]	-	-	385	K/W
from junction to ambient		[2]	-	-	209	K/W	
		[3]	-	-	169	K/W	
		_	[4]	-	-	232	K/W
			[5]	-	-	125	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

<sup>[2]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 1 cm<sup>2</sup>.

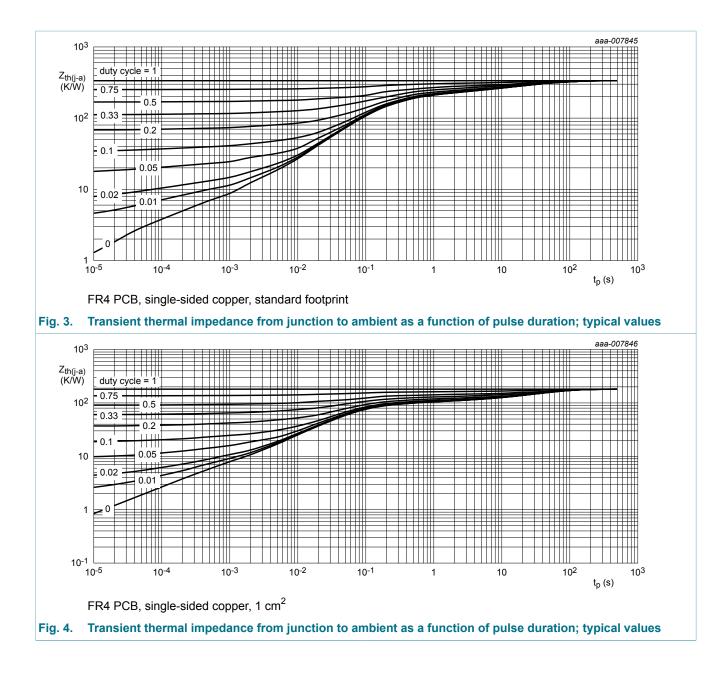
[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 6 cm<sup>2</sup>.

[4] Device mounted on an FR4 PCB, 4-layer copper, tin-plated and standard footprint.

<sup>[5]</sup> Device mounted on an FR4 PCB, 4-layer copper, tin-plated mounting pad for collector 1 cm<sup>2</sup>.

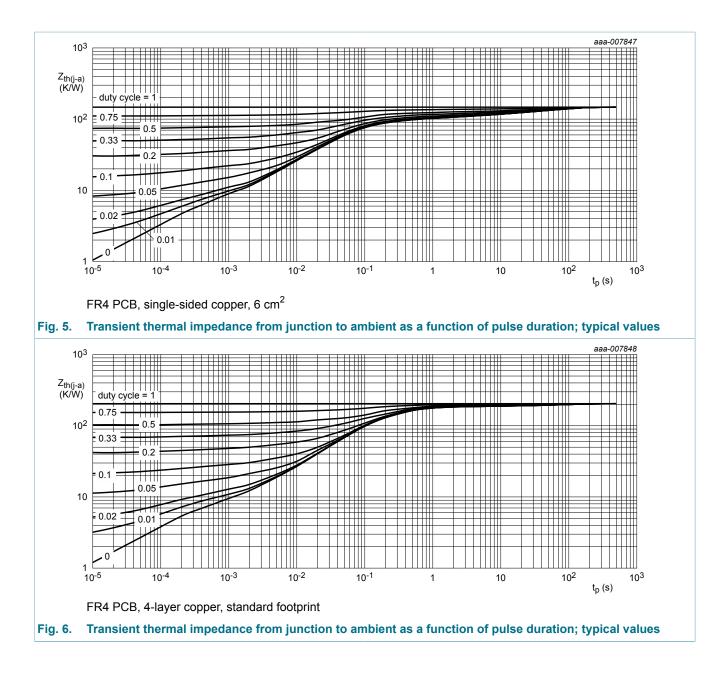
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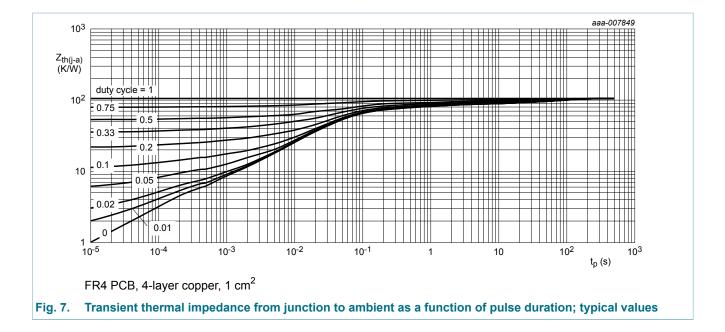
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#### 30 V, 1 A PNP low VCEsat (BISS) transistor



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#### 30 V, 1 A PNP low VCEsat (BISS) transistor



## **10. Characteristics**

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
I <sub>CBO</sub>	collector-base cut-off	V <sub>CB</sub> = -24 V; I <sub>E</sub> = 0 A; T <sub>amb</sub> = 25 °C	-	-	-100	nA
	current	$V_{CB}$ = -24 V; I <sub>E</sub> = 0 A; T <sub>j</sub> = 150 °C	-	-	-50	μA
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE}$ = -24 V; $V_{BE}$ = 0 V; $T_{amb}$ = 25 °C	-	-	-100	nA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB}$ = -5 V; I <sub>C</sub> = 0 A; T <sub>amb</sub> = 25 °C	-	-	-100	nA
h <sub>FE</sub> DC current gain	$\label{eq:Vce} \begin{array}{l} V_{CE} \texttt{=} \texttt{-2} \; V; \; I_{C} \texttt{=} \texttt{-100 mA}; \; t_{p} \texttt{\leq} \texttt{300 } \mu \texttt{s}; \\ \\ \bar{o} \texttt{\leq} \texttt{0.02} \; ; \; T_{amb} \texttt{=} \texttt{25 °C}; \; pulsed \end{array}$	250	425	-		
		$\label{eq:Vce} \begin{array}{l} V_{CE} \texttt{=} \texttt{-2} \; V; \; I_{C} \texttt{=} \texttt{-500 mA}; \; t_{p} \texttt{\leq} \texttt{300} \; \mu \texttt{s}; \\ \\ \bar{o} \texttt{\leq} \texttt{0.02} \; ; \; T_{amb} \texttt{=} \texttt{25} \; ^{\circ}C; \; pulsed \end{array}$	180	295	-	
		$\label{eq:Vce} \begin{array}{l} V_{CE} \texttt{=} \texttt{-2} \; V \texttt{;} \; I_{C} \texttt{=} \texttt{-1} \; A \texttt{;} \; t_{p} \texttt{\leq} \texttt{300} \; \mu \texttt{s} \texttt{;} \\ \\ \bar{D} \texttt{\leq} \texttt{0.02} \; \texttt{;} \; T_{amb} \texttt{=} \texttt{25} \; \texttt{^{\circ}C} \texttt{;} \; pulsed \end{array}$	130	200	-	
V <sub>CEsat</sub>	collector-emitter saturation voltage	$I_C$ = -500 mA; $I_B$ = -50 mA; $t_p \le 300 \ \mu$ s; δ ≤ 0.02 ; $T_{amb}$ = 25 °C	-	-85	-130	mV
		$I_{C} = -1 \text{ A}; I_{B} = -50 \text{ mA}; t_{p} \le 300  \mu\text{s};$ $\delta \le 0.02 \text{ ; } T_{amb} = 25 ^{\circ}\text{C}$	-	-180	-260	mV
		$I_{C}$ = -1 A; $I_{B}$ = -100 mA; pulsed; $t_{p} \le 300 \ \mu$ s; δ ≤ 0.02 ; $T_{amb}$ = 25 °C	-	-160	-240	mV
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_{C}$ = -1 A; $I_{B}$ = -100 mA; pulsed; $t_{p}$ ≤ 300 µs; δ ≤ 0.02 ; $T_{amb}$ = 25 °C	-	160	240	mΩ

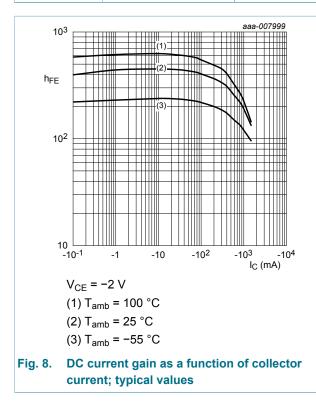
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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>BEsat</sub>	base-emitter saturation voltage	I <sub>C</sub> = -500 mA; I <sub>B</sub> = -50 mA; pulsed; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C	-	-0.88	-1	V
		$I_{C}$ = -1 A; $I_{B}$ = -50 mA; pulsed; $t_{p} \le 300 \ \mu$ s; δ $\le 0.02$ ; $T_{amb}$ = 25 °C	-	-0.93	-1.05	V
		$I_{C}$ = -1 A; $I_{B}$ = -100 mA; pulsed; $t_{p} \le 300 \ \mu$ s; δ ≤ 0.02 ; $T_{amb}$ = 25 °C	-	-0.96	-1.1	V
V <sub>BEon</sub>	base-emitter turn-on voltage	$V_{CE}$ = -2 V; I <sub>C</sub> = -0.5 A; pulsed; t <sub>p</sub> ≤ 300 μs; δ ≤ 0.02 ; T <sub>amb</sub> = 25 °C	-	-0.78	-0.9	V
t <sub>d</sub>	delay time	$V_{CC}$ = -10 V; I <sub>C</sub> = -0.5 A; I <sub>Bon</sub> = -25 mA;	-	10	-	ns
t <sub>r</sub>	rise time	I <sub>Boff</sub> = 25 mA; T <sub>amb</sub> = 25 °C	-	30	-	ns
t <sub>on</sub>	turn-on time		-	40	-	ns
t <sub>s</sub>	storage time		 -	270	-	ns
t <sub>f</sub>	fall time		-	45	-	ns
t <sub>off</sub>	turn-off time		-	315	-	ns
f <sub>T</sub>	transition frequency	$V_{CE}$ = -10 V; I <sub>C</sub> = -50 mA; f = 100 MHz; T <sub>amb</sub> = 25 °C	120	170	-	MHz
C <sub>c</sub>	collector capacitance	V <sub>CB</sub> = -10 V; I <sub>E</sub> = 0 A; i <sub>e</sub> = 0 A; f = 1 MHz; T <sub>amb</sub> = 25 °C	-	14	16	pF



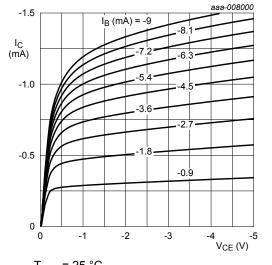
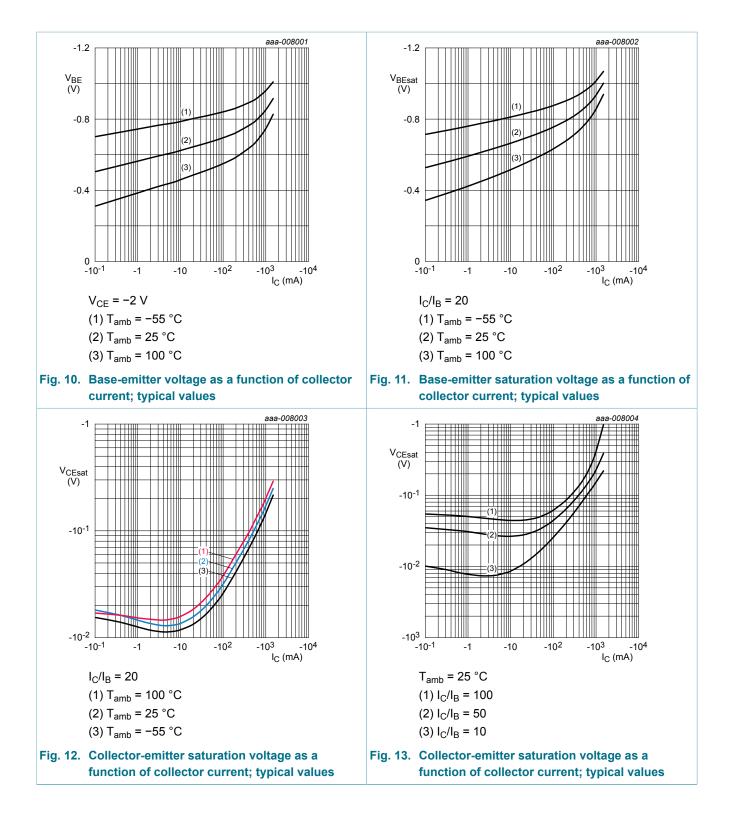




Fig. 9. Collector current as a function of collectoremitter voltage; typical values

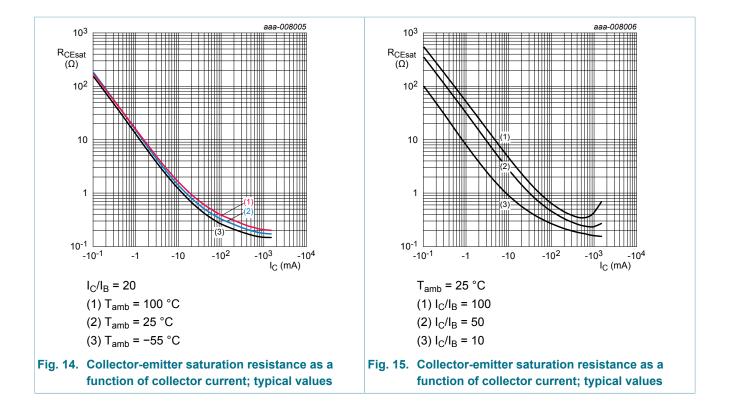
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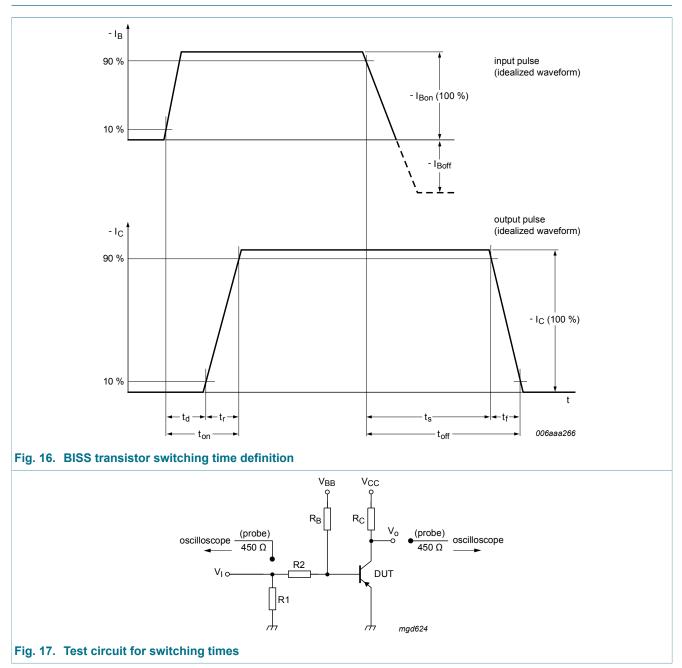


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#### 30 V, 1 A PNP low VCEsat (BISS) transistor



### 11. Test information

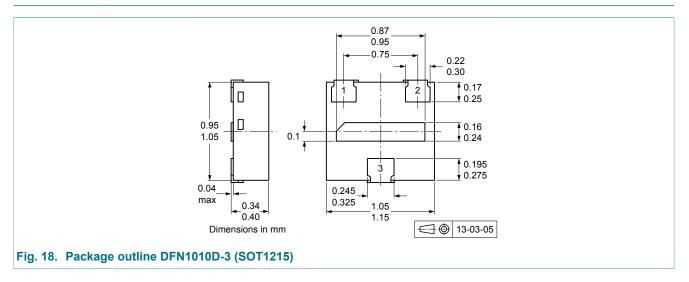


This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

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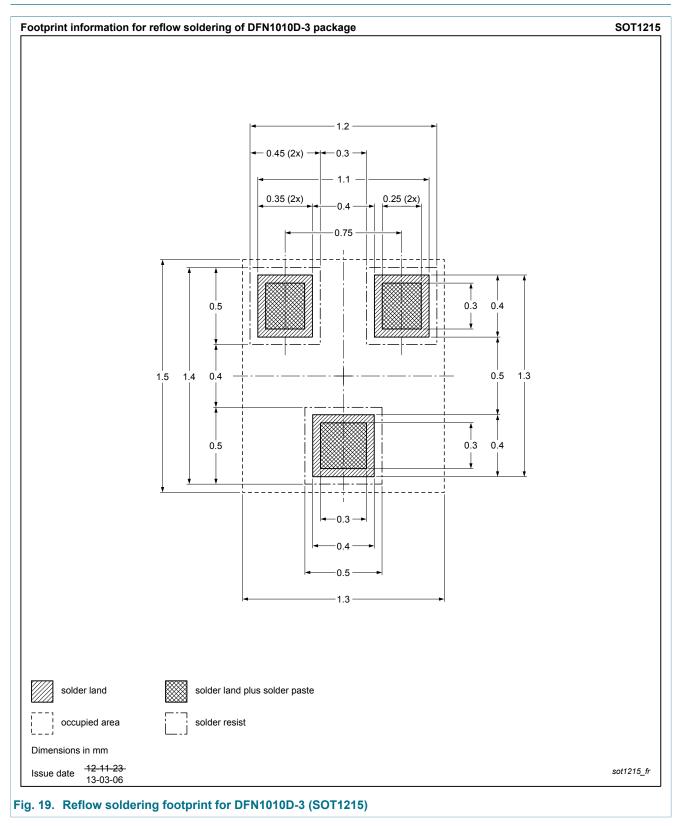
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## 12. Package outline



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## 13. Soldering



PBSS5130QA

#### 30 V, 1 A PNP low VCEsat (BISS) transistor

## 14. Revision history

Table 8. Revision history				
Data sheet ID	Release date	Data sheet status	Change notice	Supersedes
PBSS5130QA v.1	20130828	Product data sheet	-	-

#### 30 V, 1 A PNP low VCEsat (BISS) transistor

### 15. Legal information

#### 15.1 Data sheet status

Document status [1][2]	Product status [ <u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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#### 30 V, 1 A PNP low VCEsat (BISS) transistor

### 16. Contents

1	General description1
2	Features and benefits1
3	Applications1
4	Quick reference data1
5	Pinning information2
6	Ordering information2
7	Marking2
8	Limiting values3
9	Thermal characteristics4
10	Characteristics7
11	Test information11
11.1	Quality information 11
12	Package outline 12
13	Soldering13
14	Revision history14
15	Legal information15
15.1	Data sheet status 15
15.2	Definitions15
15.3	Disclaimers15
15.4	Trademarks 16

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